

The Importance of Bulk Ti³⁺ Defects in the Oxygen Chemistry on Titania Surfaces

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S Supporting Information

ABSTRACT: The role of bulk defects in the oxygen chemistry on reduced rutile $TiO_2(110)-(1 \times 1)$ has been studied by means of temperature-programmed desorption spectroscopy and scanning tunneling microscopy measurements. Following O₂ adsorption at 130 K, the amount of O₂ desorbing at ~410 K initially increased with increasing density of surface oxygen vacancies but decreased after further reduction of the $TiO_2(110)$ crystal. We explain these results by withdrawal of excess charge (Ti^{3+}) from the $TiO_2(110)$ lattice to oxygen species on the surface and by a reaction of Ti interstitials with O adatoms upon heating. Important consequences for the understanding of the O_2 -TiO₂ interaction are discussed.

The interaction of oxygen with titania (TiO_2) is crucial in fields such as heterogeneous catalysis, photocatalysis, and gas sensing,¹⁻¹⁶ but the role of oxygen in these applications is still unclear.³ To shed light on the O₂-TiO₂ interaction at the atomic scale, model studies of rutile TiO₂(110) crystals under ultrahigh vacuum (UHV) have been performed.^{1-3,8-13,17-27} Presently, the literature on the O₂-TiO₂ interaction is surprisingly heterogeneous, and various conflicting models have been proposed.^{8,9,18-23} For example, at adsorption temperatures (T_{ad}) \geq 400 K, the important role of Ti interstitials in the oxygen chemistry has been recognized;^{8,11} however, for $T_{ad} \leq$ 300 K, it has been proposed that surface defects control the oxygen chemistry on reduced rutile TiO₂(110).¹⁸⁻²¹

The rutile TiO₂(110) – (1 × 1) surface consists of alternating rows of fivefold-coordinated Ti atoms and protruding, twofold-coordinated bridging oxygen atoms (O_{br}). The Ti atoms underneath the O_{br} atoms are sixfold-coordinated, as are the other Ti atoms in stoichiometric rutile. Ar⁺-sputtered and vacuum-annealed TiO₂(110) crystals are n-type semiconductors because of bulk defects such as Ti interstitials, O vacancies, and crystallographic shear planes.^{8,9,11,13} The surfaces of vacuum-annealed TiO₂(110) crystals are characterized by the presence of O_{br} vacancies (O_{br} vac.) and/or H adatoms (H_{ad}, often also denoted as OH_{br}).^{8–10,17} This is different from anatase TiO₂(101), for which scanning tunneling microscopy (STM) studies have revealed the absence of surface O vac. defects.²⁸

It is generally accepted that adsorbed O₂ species acquire negative charge upon adsorption on TiO₂ surfaces.^{1,2,8,13,18,21,29,30} Adsorbed oxygen species are capable of causing upward band bending, which is of great importance in many of the applications of TiO₂.^{8,13,15,16} In

most of the previous studies, an idealized model has been invoked in which O_2 molecules adsorb at O_{br} vac. sites and charge donation from other defects does not occur (Figure 1, model A).^{18,19} Within model A, it has been proposed that the O_2 desorption peak at ~410 K^{2,18,19,22} is associated with O_2 desorption from O_{br} vac. defects.^{18,19} Recently, we proposed another model to explain the desorption of O_2 molecules at ~410 K.²² Within this model, O_2 molecules and O adatoms (O_{ad}) are postulated to withdraw the charge primarily from the near-surface region (Figure 1, model B).^{13,17,22,24} The desorption of O_2 molecules at ~410 K would then be caused by a depletion of the excess charge in the near-surface region that occurs when outdiffusing Ti interstitials react with the O_{ad} species on the surface.²² The O_{ad} species appearing on the surface directly after O_2 exposure at 120–130 K result from O_2 dissociation reactions at O_{br} vac. defects (first channel).^{13,17,22}

In this work, we utilized a combination of temperature-programmed desorption (TPD) and STM to explore further the O_2 -TiO₂(110) interaction and the role of defects. The O₂ TPD peak at ~410 K was monitored as a function of the TiO₂(110) crystal reduction state, and the surface morphology before and after oxidation of the crystal was studied by high-resolution STM.

The TPD and STM experiments were carried out in a UHV chamber equipped with a quadrupole mass spectrometer (QMS), a home-built, variable-temperature Aarhus scanning tunneling microscope,³¹ and standard facilities for sample preparation and characterization.^{17,22} The differentially pumped QMS was connected to the chamber via a closed cone with a small aperture ($d \approx 3 \text{ mm}$) facing the sample at a distance of 1 mm, ensuring that only molecules desorbing from the sample could reach the QMS filament. The sample temperature was measured using a K-type thermocouple spot-welded to the sample plate with the thermocouple in direct contact with the crystal. The $TiO_2(110)$ crystal was prepared by applying cycles of Ar^+ sputtering (1 kV, \sim 1 nA, 8 min) and vacuum annealing (20 min). Initially, the crystal was annealed at 850 K, but in the course of \sim 80 preparation cycles, the annealing temperature was gradually increased to a final value of 960 K. Oxygen exposures are given in langmuirs (1 L = 1.33×10^{-6} mbar \cdot s), and the defect densities are given in % monolayers (% ML), where 1 ML is the density of the (1×1) unit cell $(5.2 \times 10^{14} \text{ cm}^{-2})$.

Figure 2 shows O_2 TPD spectra obtained for (i) a clean, reduced TiO₂(110) surface with O_{br} vac. defects (*r*-TiO₂) and (ii) a TiO₂(110) surface with H_{ad} species (*h*-TiO₂). On *h*-TiO₂, no O_{br} vac. persisted, as all of them were healed via water

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Figure 1. Schematic diagram illustrating two models for O_2 adsorption on reduced Ti $O_2(110)$ at ~130 K. Model A: purely O vac.-assisted adsorption. Model B: O_2 adsorption enabled predominantly through charge withdrawal from Ti³⁺ defects in the near-surface region.



Figure 2. O_2 TPD spectra (heating rate = 2 K/s) obtained for *r*- and *h*-TiO₂ using 20 L O₂ (saturation). A medium-reduced, vacuum-annealed TiO₂(110) crystal was used in both experiments.

dissociation reactions.^{9,17,24} Both experiments were conducted with a medium-reduced TiO₂(110) crystal, and in each case, the clean surface had O_{br} vac. densities of ~8% ML. Following 20 L O₂ exposure at 130 K, the amounts of O₂ desorbed from *r*- and *h*-TiO₂ between 350 and 450 K were very similar, in agreement with previous results.²⁰ As revealed in Figure 2, the line shapes of the two O₂ TPD spectra differed somewhat, with the O₂ molecules being slightly more stabilized on *h*-TiO₂. All of the charge-donating defects (O_{br} vac., H_{ad}, and bulk-defects such as Ti interstitials) may contribute to the stabilization of O₂ molecules on the surface.^{29,30,32} Therefore, solely on the basis of the O₂ TPD spectra displayed in Figure 2, it cannot be deduced which defects are the most relevant ones.

Figure 3 shows the O_2 TPD peak areas found in a series of O_2 TPD experiments that were conducted using the same sample but with the crystal in different reduction states. In order to provide a measure of the bulk-reduction state, we determined the $O_{\rm br}$ vac. densities by means of STM measurements on the corresponding *r*-TiO₂(110) surfaces before the TPD experiments were performed (see the Supporting Information). In the TPD experiments, both *r*- and *h*-TiO₂(110) surfaces were studied, and all of the surfaces were saturated with O_2 at 130 K. The O_2 TPD peak areas can be compared for *r*- and *h*-TiO₂(110) surfaces because equal amounts of O_2 desorb from the surface provided that the bulk reduction of the crystals and $T_{\rm ad}$ are similar (cf. Figure 2). As shown in Figure 3, the amount of desorbing O_2 increased between 6 and 8% ML $O_{\rm br}$ vac. density, and a maximum was observed at ~8.3% ML. Surprisingly, with



Figure 3. O₂ TPD peak area as a function of the crystal reduction state. The density of O_{br} vac. defects on the terraces (estimated from corresponding STM analysis; see the Supporting Information) was taken as a measure of the bulk-reduction state. O₂ was dosed at 130 K onto *r*- and *h*-TiO₂ surfaces, respectively. In all cases, at least 20 L was dosed to saturate the crystal surface with oxygen species. The plot is based on O₂ TPD spectra that were all collected from the same $TiO_2(110)-(1 \times 1)$ crystal.

further reduction of the crystal, the amount of desorbing O_2 declined significantly. This is a remarkable result that is difficult to explain within model A. If O_2 were stabilized on the surface exclusively through charge withdrawal from surface defects ($O_{\rm br}$ vac. and $H_{\rm ad}$), the amount of desorbing O_2 would be directly proportional to the density of these defects, which was not the case. However, the decline of the O_2 TPD peak area for higher crystal reduction states (i.e., $O_{\rm br}$ vac. densities higher than ~8.3% ML) can be rationalized within model B, as will be discussed below.

On low-reduced TiO₂(110) crystals, only a small amount of O₂ is adsorbed (i.e., the amount of desorbing O₂ at ~410 K is limited by the adsorption at 130 K). With increasing bulk reduction of the TiO₂(110) crystal, more excess charge is available on the surface, and thus, more O₂ adsorbs at 130 K. As a result, the O₂ TPD peak at ~410 K increases initially for O_{br} vac. densities between 6 and 8% ML. It should be noted, however, that a substantial amount of O₂ can be lost upon heating of the crystal through O₂ dissociation reactions.^{22,23} Recent STM studies revealed the existence of a non-vacancy-assisted O₂ dissociation channel that leads to the formation of paired O_{ad} in the Ti troughs (second channel).^{9,13,22,23} On low- and medium-reduced TiO₂(110) crystals, this second O₂ dissociation channel sets in between 150 and 180 K.²²

The amount of desorbing O₂ at ~410 K is high when two conditions are fulfilled: (i) O₂ adsorption at 130 K is sufficiently high, and (ii) only a small amount of O₂ is lost via O₂ dissociation upon heating of the crystal. In the course of the TPD experiments, O₂ molecules first dissociate in the Ti troughs and residual O_{br} vac. sites, leading to the formation of additional O_{ad}. At ~360 K, the Ti interstitials in the near-surface region begin to diffuse toward the surface, where they react with O_{ad} species.²³ In this way, small TiO_x islands with $x \approx 2$ are formed on the terraces.^{13,22,23} Simultaneously, the residual intact O₂ molecules begin to desorb from the surface because the Ti³⁺ excess charge in the near-surface region is depleted.²² On the more-reduced TiO₂(110) crystals, more Ti³⁺ excess charge is available in the bulk and the near-surface region. As a result, the dissociation of O₂ molecules in the Ti troughs





Figure 4. STM images (constant-current mode, tunneling voltage $\approx +1.25$ V, tunneling current ≈ 0.1 nA) obtained after 20 L O_2 exposure at 135 K followed by annealing at 623 K for 120 s for (a) a low-reduced TiO_2(110) crystal and (b) a high-reduced crystal. The $O_{\rm br}$ vac. densities on the terraces before O_2 exposure were (a) ~ 3.5 and (b) $\sim 10.0\%$ ML. Symbols indicate $O_{\rm br}$ vac. (solid-line squares) and TiO_x islands of identical sizes (dashed-line squares, solid-line circles, and dashed-line circles).

(second channel) is hindered by only a low energy barrier, as revealed by means of density functional theory calculations.^{13,30} This explains why the second O2 dissociation channel opens at lower temperature on medium-reduced crystals than on low-reduced ones.²² For high-reduced $TiO_2(110)$ crystals, we expect an increase in the O₂ dissociation rate upon heating of the crystal because the density of charge donors is even higher than for medium-reduced crystals. Directly after saturation of high-reduced $TiO_2(110)$ crystals with O_2 at 130 K, the density of O_{ad} was ~8% ML (not shown). A substantial portion of the Ti³⁺ excess charge in the near-surface region may have been depleted as a result of the adsorption of these $O_{ad}^{21,22}$ Since O_2 and O_{ad} compete for the available Ti^{3+} excess charge, 21,22 we speculate that the initial O₂ coverage on high-reduced $TiO_2(110)$ crystals is only slightly larger than that on mediumreduced $TiO_2(110)$ crystals. When high-reduced $TiO_2(110)$ crystals are heated, many more oxygen species can react with the Ti interstitials than in the case of less-reduced samples, which explains the decline of the O_2 TPD peak area with increasing crystal reduction (cf. Figure 3).

The STM images displayed in Figure 4 directly show that the amount of oxygen incorporation into the crystal depends on the reduction state of the $TiO_2(110)$ crystal (i.e., on the available Ti^{3+} excess charge). Following the 20 L O₂ exposure at 135 K and annealing at 620 K for 120 s, TiO_x islands (with similar densities) appeared on the surface in both experiments. However, the average size of the TiO_x islands was much smaller for the lowreduced crystal (Figure 4a) than on the high-reduced crystal (Figure 4b), indicating that more O_2 reacted with the highreduced crystal. It should be noted that the bulk of high-reduced $TiO_2(110)$ crystals constitutes a reservoir of Ti interstitials and possible other bulk defects in which the number of such species is much higher than the number of adsorption sites on the surface. The STM data presented in Figure 4 support the scheme described above, explaining why only a small amount of O2 desorbs at \sim 410 K from the high-reduced TiO₂(110) crystals.

The results presented here reveal that model B in Figure 1 describes the O₂-TiO₂ interaction more completely than model A, indicating that the oxygen chemistry on reduced TiO₂(110) is governed by bulk defects. While the latter is apparent for $T_{\rm ad} \geq 360 \text{ K}$,^{8,11,23} the strong influence of charge-donating bulk defects is less obvious for $T_{\rm ad} < 360 \text{ K}$ because the diffusion of Ti interstitials is kinetically hindered at these temperatures.²³

However, the bulk Ti³⁺ defects such as Ti interstitials are also essential for $T_{\rm ad}$ < 360 K because these defects provide most of the charge (very probably more than 90%)²² that is required for the adsorption of O₂ and O_{ad} species. The presented results indicate that Ti³⁺ excess charge can easily be withdrawn by the adsorbates on the surface from deeper layers of the $TiO_2(110)$ crystal, even at 130 K. This conclusion is consistent with transport³³ and thin-film growth³⁴ studies as well as with electron paramagnetic resonance spectroscopy studies addressing TiO2based materials for applications in photocatalysis.⁴⁻⁷ Such an ionosorption model may reconcile previously published experimental data on rutile $TiO_2(110)$ obtained at low and high T_{ad} as well as numerous data obtained in the fields of materials science and surface science. The insight gained for rutile $TiO_2(110)$ crystals may also be applicable to anatase TiO_2 and other reducible oxides such as SnO₂ and ZnO.

ASSOCIATED CONTENT

Supporting Information. Background literature summary, experimental details, and additional STM data. This material is available free of charge via the Internet at http://pubs.acs.org.

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